

**Search Notes**

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Examiner

Hien Tran

Applicant(s)/Patent under  
Reexamination

HUANG ET AL.

Art Unit

1764

**SEARCHED**

Class	Subclass	Date	Examiner
422	177, 180, 211, 222	11/7/2005	HT
502	527.18,	11/7/2005	HT
502	527.19,	11/7/2005	HT
502	527.24	11/7/2005	HT
502	439	11/7/2005	HT
502	259	11/7/2005	HT
502	335	11/7/2005	HT
502	337	11/7/2005	HT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Image class/subclass search / Inventors' names search / text search	11/7/2005	HT